

Notice of References Cited

Application/Control No.

10/0511201

Applicant(s)/Patent Under
Reexamination
FONKWE ET AL

Examiner

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Art Unit

1623

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,143,324	11-2000	Michaud et al.	424/465
	B	US-6,607,748	08-2003	Lenaerts et al.	424/464
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/03677	01-2001	WIPO	Tanner et al	A61K 9/48
	O	WO 01/91721	12-2001	WIPO	Gilleland et al	A61K 9/00
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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